

**Search Notes**

Application/Control No.

10/826,127

Examiner

Brian E. Miller

Applicant(s)/Patent under  
Reexamination

FURUKAWA ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
360	324.1		
360	324.11		
360	324.12		
360	324.2	3/19/2006	BEM
updated	as above	8/29/2006	BEM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
reviewed parent application- 10/218247	3/19/2006	BEM